# **Dendogram-based SVM for Multi-Class Classification**

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This paper presents a new approach called dendogrambased support vector machines (DSVM), to treat multi-First, the method consists to build class problems. a taxonomy of classes in an ascendant manner done by ascendant hierarchical clustering method (AHC). Second, SVM is injected at each internal node of the taxonomy in order to separate the two subsets of the current node. Finally, for classifying a pattern query, we present it to the "root" SVM, and then, according to the output, the pattern is presented to one of the two SVMs of the subsets, and so on through the "leaf" nodes. Therefore, the classification procedure is done in a descendant way in the taxonomy from the root through the end level which represents the classes. The pattern is thus associated to one of the last SVMs associated class. AHC decomposition uses distance measures to investigate the class grouping in binary form at each level in the hierarchy. SVM method requires little tuning and yields both high accuracy levels and good generalization for binary classification. Therefore, DSVM method gives good results for multi-class problems by both, training an optimal number of SVMs and by rapidly classifying patterns in a descendant way by selecting an optimal set of SVMs which participate to the final decision. The proposed method is compared to other multi-class SVM methods over several complex problems.

Keywords: AHC, SVM, multi-class problems.

### 1. Introduction

Achieving both high accuracy and good generalization for complex problems of classification is a challenging problem, especially when data distribution is not linear and the number of classes is large. In this context, support vector machines have demonstrated superior performance [2]. However, SVM was originally designed for binary classification and its extension for multi-class classification is still an on-going research issue [3]. Actually, we distinguish two types of multiclass SVM approaches: one by directly considering all data in one optimization formulation [11] and the other by building and combining several binary classifiers [12,13]. In general, it is computationally more expensive to solve a multi-class problem than a binary problem with the same number of data. This work is devoted to the second approach, i.e. it solves a multi-class problem by decomposing it to several binary problems in a hierarchical way.

The popular methods which decompose multiclass problems into many binary class problems are "one-against-all" and "one-against-one" approaches [14].

The "one-against-all" approach is a simple and effective method for multi-class classification. Suppose there are K classes in the problem. We partition these K classes into two-class problems: one class contains patterns in one "true" class and the "others" class combines all other classes. A two-class classifier is trained for this two-class problem. We then partition the K classes into another original class, and the 'others' class contains the rest. Another two way classifier is trained. This procedure is repeated for each of the K classes, leading to K two-way trained classifiers.

In the recognition process, the system tests the new query pattern against each of the K twoway classifiers, to determine if it belongs to the given class or not. This leads to K scores from the K classifiers. Ideally, only one of the K classifiers will show a positive result and all other classifiers will show negative results, assigning the query pattern to a unique class. In practice, however, many patterns show positive on more than one class, leading to ambiguous classification results, the so-called 'False positive' problem. One of the main reasons for the false positive problem is that the decision boundary between one 'true' class and its complementary 'others' class cannot be drawn cleanly, due to the complexity of the 'others' class and close parameter proximity of some patterns.

In the "one-against-one" method, we train twoway classifiers between all possible pairs of classes; there are K(K-1)/2 of them. A new query pattern is then tested against these K(K-1)/2 classifiers and K(K-1)/2 scores (votes) are obtained. In a perfect case, the correct class will get the maximum possible votes, which is (K-1) for all class-class pairs; and votes for other (K-1) classes would be randomly distributed, leading to [K(K-1)/2-K-1]/(K-1) = (K-2)/2 per class on average.

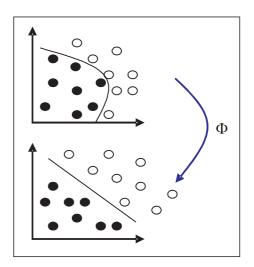
Subsequently, a K-class problem needs K(K-1)/2 binary SVMs with "one-against-one" approach and K SVMs for the "one-against-all" approach. Although the "one-against-one" approach demonstrates superior performance, it may require prohibitively expensive computing resources for many real world problems. The "one-against-all" approach shows somewhat less accuracy, but still demands heavy computing resources, especially for real time applications.

The new method proposed in this paper provides an alternative to the two presented methods. The proposed DSVM takes advantage of both the efficient computation of the ascendant hierarchical clustering of classes and the high classification accuracy of SVM for binary classification. Although DSVM needs (K-1) SVMs for K-class problem in the training phase, for the testing phase DSVM requires an optimal set of SVMs selected in a descendant way from the root of the taxonomy through the selected class among the "leaf" nodes.

In Section 2, we present the basic concept of SVM for linear and non linear problems. In Section 3 we describe the concept of our DSVM method. Finally, Section 4 shows our results obtained by comparing the proposed method with other ones over several problems.

### 2. Support Vector Machines and Binary Classification

The support vector machine is originally a binary classification method developed by Vapnik and colleagues at Bell laboratories [5, 6], with algorithm improvements by others [7, 9]. SVM consists of projecting the input vectors into a high dimensional feature space, then searches for the linear decision boundary that maximizes the minimum distance between two class groups (Figure 1).



*Fig. 1.* General principle of SVM: projection of data in an optimal dimensional space.

In Figure 1 we can see that data are not linearly separable in the initial space a) and after projection (by function:  $\Phi$ ) they become separable in the high dimensional space b). SVM then consists of finding the optimal boundary for separating the positive class (dark circles) from the negative one (white circles).

SVM separate between these two classes via a hyperplane that is maximally distant from the positive samples and from the negative ones (Figure 1), then 'plot' the test data at the high dimensional space, distinguish whether it belongs to positive or negative according to the optimal hyperplane.

For a binary classification problem with input space X and binary class labels Y :

$$Y \in \{-1, 1\}$$
.

Giving training samples  $(y_1, x_1)$ , ...,  $(y_l, x_l)$ .

$$y_i \in \{-1, 1\}$$
(1)

the goal of SVM is to search for the optimal hyperplane

$$w \cdot x + b = 0 \tag{2}$$

with variables *w* and *b* that satisfy the following inequality

$$y_i(w \cdot x_i + b) \ge 1, \quad i = 1, \dots, l, \quad (3)$$

defining the minimum distance between two class groups in the new projection.

$$d(w,b) = \min_{x/y=+1} \frac{x^T \cdot w}{||w||} - \max_{x/y=-1} \frac{x^T \cdot w}{||w||}$$
(4)

From e.q. (3),  $\min_{\{x:y=1\}} x.w=1$  and  $\max_{\{x:y=-1\}} x.w=-1$ . Substituting back into e.q. (4), yields

$$d(w_0, b_0) = \frac{2}{||w_0||} = \frac{2}{\sqrt{w_0 w_0}}$$

For a given training set w, b that maximizes  $d(w_0, b_0)$  solves the following quadratic optimization problem:

$$\min_{w} \frac{1}{2} w.w 
s.t. y_i(w.x_i + b) \ge 1 \quad i = 1, \dots, l.$$
(5)

If the given training sample set is linearly separable, the optimization problem (5) has feasible solutions. The optimal solution w, and b forms the best hyperplane that maximizes the margin between two different classes in the new projection. Because SVM search for the best separation hyperplane instead of the highest training sample accuracy, they never over-train on a sample data set. If the parameters are properly selected, SVM typically produce both excellent classification results and good generalization if parameters are properly selected. Not every problem is guaranteed to be linearly separable, so a soft margin hyperplane SVM was developed to separate the training set with a minimal number of errors [5].

A number of candidate kernel functions have been used in SVM, including polynomial

$$K(x,y) = (1+x.y)^d ,$$

exponential RBF

$$K(x, y) = exp\left(-\frac{||x - y||}{2\sigma^2}\right)$$

and Gaussian RBF

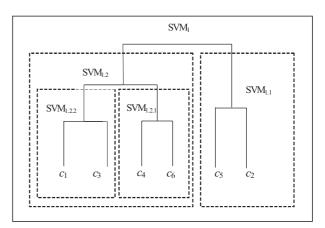
$$K(x,y) = exp\left(-\frac{||x-y||^2}{2\sigma^2}\right) \,.$$

#### 3. Dendogram-based SVM

The DSVM method that we propose consists of two major steps: (1) computing a clustering of the known classes and (2) associating a SVM at each node of the taxonomy obtained by (1).

Let's take a set of samples  $x_1, x_2, ..., x_n$  labeled each one by  $y_i \in \{c_1, c_2, ..., c_k\}$ , k is the number of classes  $(k \le n)$ .

The first step of DSVM method consists of calculating k gravity centers for the k known classes. Then AHC clustering is applied over these k centers (Figure 2).



*Fig. 2.* Grouping classes in hierarchical way by AHC method.

Figure 2 shows an example of a taxonomy done by AHC [16] algorithm over the k classes.

In the second step, each SVM is associated to a node and trained with the elements of the two subsets of this node. For example, in Figure 2 which illustrates clustering of 6 classes SVM<sub>1</sub> is trained by considering elements of  $\{c_5, c_2\}$  as positives and elements of  $\{c_1, c_3, c_4, c_6\}$  as

negatives; SVM<sub>1,2</sub> is trained by considering elements of  $\{c_4, c_6\}$  as positives and elements of  $\{c_1, c_3\}$  as negatives. The concept is repeated for each SVM associated to a node in the taxonomy. In final, we will train (k - 1) SVM for *k*-class problem.

The advantage of training in DSVM is to a priori separate the classes in a hierarchical way. That facilitates the class separation for the SVM. In fact, SVM<sub>1</sub> found easily boundary separation between  $\{c_5, c_2\}$  and  $\{c_1, c_3, c_4, c_6\}$ . The level of difficulty for boundary separation increases from the root through the leaves. The idea of DSVM is that it is preferable to solve many small problems in a hierarchical way than to solve a complex great problem. For classifying a pattern query, DSVM presents it to the "root" SVM which provides an output for right or left on the taxonomy. The procedure is repeated for each selected node in the "way" of the classification (Figure 3) until arriving to a leaf which finally represents the associated class for our pattern query.

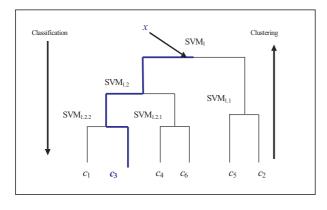


Fig. 3. Classification way by DSVM.

In Figure 3 we show the classification way of a given pattern: x via DSVM. x is presented to  $SVM_1$  (root), then output of  $SVM_1$  is : x  $\in$  $\{c_1, c_3, c_4, c_6\}$ . Next, x is presented to SVM<sub>1.2</sub>, the output decision is  $x \in \{c_1, c_3\}$ . Finally, x is presented to SVM<sub>1.2.2</sub> when the output is: x $\in$  $\{c_3\}$ . DSVM provides a trace of classification of x which is  $SVM_1 \rightarrow SVM_{1,2} \rightarrow SVM_{1,2,2}$ . We can see that classification procedure is more optimal with DSVM than with the other multi class SVM and it provides a unique solution for the pattern x. In fact, in our example, the system requires 3 among the 5 trained SVMs for making the decision.

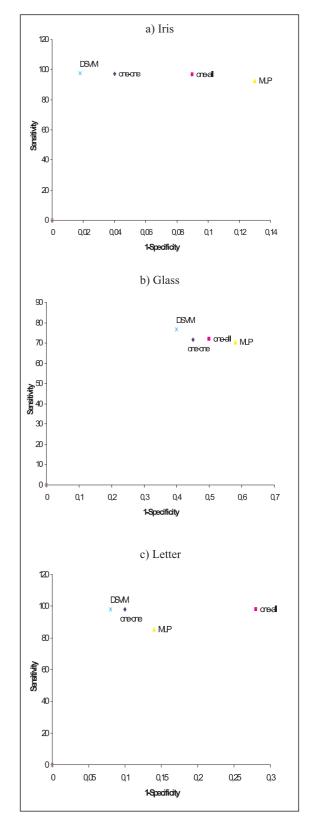


Fig. 4. ROC curves for the three problems.

#### 4. Experiment Results

#### 4.1. Data for Validation

We have performed several experiments on three known problems from the UCI Repository of machine learning databases [15]. The chosen databases are: "Iris", "Glass" and "Letter". We give the problem statistics in Table 1.

problem	#training data	#testing data	#class	#attributes
Iris	100	50	3	4
Glass	142	72	6	9
Letter	10000	5000	26	16

#### Table 1. Problem statistics

In Table 1 we can see that for each problem we have used 2/3 of data for training and 1/3 for testing, and that the 3 problems differ in dimensional input space, in size of database and in the number of classes.

#### 4.2. Accuracy Measures

The goal of these experiments is to evaluate our method vs. "one-against-one", "one-againstthe other" and MLP (Multi layer perceptron) methods. The most important criterion in evaluating the performance of these methods is their accuracy rate. In addition, we will present the time of training of each method and the number of trained SVMs for multi class SVM methods. Accuracy of the results obtained with discriminative methods is commonly measured by the quantity of true positives (TP), true negatives (TN), false positives (FP) and false negatives (FN). In addition to these quantities, standard sensitivity and specificity measures defined by:

Sensitivity=TP/(TP+FN),

Specificity=TN/(TN + FP),

are also useful in assigning the classification accuracy. All these quantities are used in the evaluation of classification methods in this work.

#### 4.3. Results

Experiments were performed using "one-againstone", "one-against-all", Multi Layer perceptron (MLP) and the proposed DSVM methods. Average classification accuracies for test data of each problem conducted with each classifier are listed in Table 2.

problem	One-against -one	One- against -all	MLP	DSVM
Iris	97.333 [83.23,100]	96.667 [81.9, 100]	92.48 [74.42, 100]	97.619 [83.83, 100]
Glass	71.495 [50.38,90.43]	71.963 [50.92, 90.78]	70.340 [49.06, 89.56]	76.76 [56.58, 94.74]
Letter	97.98 [97.18,98.71]	97.88 [97.06, 98.63]	85.236 [83.28, 87.14]	98.012 [97.21, 98.74]

Table 2. Accuracy comparison between methods.

Table 2 presents the result of comparing the four methods. For SVM-based methods, Gaussian RBF kernel is used in the training phase. MLP is trained with different number of hidden neurons for each problem, and optimal numbers given best MLP's accuracy are selected.

The values between brackets represent the confidence intervals for 95% confidence level, computed as described in [1]. In Figure 4, the ROC (Receiver operating characteristics) space shows that DSVM approach gives better total result in both sensitivity and specificity than the other methods. In Table 3 we also report the training time and the number of trained SVMs.

problem	One- against -one Time/ #svm	One- against -all Time/ #svm	MLP Time	DSVM Time/ #svm
Iris	0.04/3	0.10/3	0.047	0.03/2
Glass	2.42/15	10/6	140	0.09/5
Letter	298.08/325	1831/26	4500	140/25

Table 3. Training time (in sec) and #SVMs.

We can see that both training time and number of trained SVMs are considerably decreased in problem Classes Sensitivity (%) Specificity (%) Iris Class1 100 100 Class2 92.87 100 100 94 Class3 Glass Class1 84 68 Class2 86 84 0 0 Class3 93.56 Class4 100 100 Class5 100 97 Class6 82 Letter Class1 98 100 100 92 Class2 Class3 96 93 98 97 Class4 Class5 100 93 96 Class6 92 Class7 97 99 Class8 100 88 Class9 97 87 Class10 99 91 100 Class11 92 98 94 Class12 99 91 Class13 Class14 97 100 93 Class15 97 98 97 Class16 Class17 94 98 100 94 Class18 Class19 98 88 Class20 97 92 100 Class21 78 Class22 99 96 98 Class23 100 Class24 97 96 Class25 97 75 98 Class26 88

DSVM learning method. In addition, the classi-

fication time is also low because of the optimal

set of SVMs selected in a descendant way in the

*Table 4*. Detailed test results for different classes of the three problems with DSVM.

taxonomy.

The results of the classification of DSVM for each class are given in detail for each problem in Table 4.

The sensitivity and specificity are the range of 92-100 % and 94-100%, respectively, for "Iris" problem, 94-100% and 75-100% for "Letter" problem. For "Glass" problem, globally the accuracy is good for all classes except class 3, because the samples of this class are "very" non-linearly distributed in the input space and they are generally recognized in class 1. That results in confusion between the two classes.

## 5. Conclusion and Future Works

A new hierarchical support vector machines (DSVM) approach has been developed. This method utilizes a taxonomy of classes and decomposes a multi-class problem to a descendant set of binary-class problems. AHC method is used to group all classes in an ascendant hierarchy. This clustering allows us to separate the classes and to build different subsets from database for different sub-problems. Then SVM classifier is applied at each internal node to construct the best discriminant function of a binary-class problem.

In this paper, DSVM was evaluated using a series of experiments. Compared with the two famous multi-class SVM methods and a MLPbased neural networks DSVM consistently achieves both high classification accuracy and good generalization. DSVM takes its advantage from two good methods: (1) AHC clustering, which uses distance measures to investigate the natural class grouping in hierarchical way and (2) original binary SVM classifiers to separate the different classes because of their solid mathematical foundations. Combining these two methods, DSVM extends binary-SVM to a fast multi-class classifier.

Future work reports to develop a dynamic Kernel in the taxonomy for treating the different binary-classification. This dynamic kernel will take into account the difficulty of data separation of positive and negative samples from the root through the leaf nodes in the hierarchy.

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